

# AOD66406/AOI66406

40V N-Channel AlphaSGT™

## **General Description**

- Trench Power AlphaSGT<sup>TM</sup> technology
- Low R<sub>DS(ON)</sub>
- Logic Level Driving
- Excellent Gate Charge x R<sub>DS(ON)</sub> Product (FOM)
- RoHS and Halogen-Free Compliant

## Applications

- High Frequency Switching and Synchronous Rectification
- DC-Motor Driver

## **Product Summary**

 $\begin{array}{lll} V_{DS} & 40V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 60A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 6.1 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 4.5V) & < 9.4 m\Omega \end{array}$ 

100% UIS Tested 100% Rg Tested



TO-252 DPAK		TO-251A IPAK		
Top View	<b>Bottom View</b>	Top View	<b>Bottom View</b>	O D
D R		D R G D S	D G S D G	G
	AOD66406	Α	OI66406	

Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOD66406	TO-252	Tape & Reel	2500
AOI66406	TO-251A	Tube	4000

## Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V <sub>DS</sub>	40	V
Gate-Source Voltage		V <sub>GS</sub>	±20	V
Continuous Drain	T <sub>C</sub> =25°C	1	60	
Current <sup>G</sup>	T <sub>C</sub> =100°C	I <sub>D</sub>	45	A
Pulsed Drain Current <sup>Ċ</sup>		I <sub>DM</sub>	150	
Continuous Drain	T <sub>A</sub> =25°C	1	25	^
Current	T <sub>A</sub> =70°C	IDSM	20	A
Avalanche Current <sup>C</sup>		I <sub>AS</sub>	20	A
Avalanche energy L=0.3mH <sup>C</sup>		E <sub>AS</sub>	60	mJ
	T <sub>C</sub> =25°C	P <sub>D</sub>	52	W
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100°C	F <sub>D</sub>	20.5	vv
	T <sub>A</sub> =25°C	Р	6.2	10/
Power Dissipation A	T <sub>A</sub> =70°C	P <sub>DSM</sub>	4.0	W
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C

Thermal Characteristics					
Parameter		Symbol	Тур	Max	Units
Maximum Junction-to-Ambient A	t ≤ 10s	≤ 10s		20	°C/W
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	40	50	°C/W
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1.9	2.4	°C/W



### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units		
STATIC PARAMETERS								
$BV_{DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		40			V	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =40V, V <sub>GS</sub> =0V				1		
			T <sub>J</sub> =55°C			5	μA	
$I_{GSS}$	Gate-Body leakage current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V				±100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS,}I_{D}=250\mu A$		1.5	2.0	2.5	V	
		$V_{GS}$ =10V, $I_D$ =20A			5.0	6.1	mΩ	
$R_{DS(ON)}$	Static Drain-Source On-Resistance		T <sub>J</sub> =125°C		7.5	9.1		
		$V_{GS}$ =4.5V, $I_D$ =20A			7.4	9.4	mΩ	
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_D$ =20A	V <sub>DS</sub> =5V, I <sub>D</sub> =20A		70		S	
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A, V <sub>GS</sub> =0V			0.7	1	V	
Is	Maximum Body-Diode Continuous Current					50	Α	
DYNAMIC	PARAMETERS							
C <sub>iss</sub>	Input Capacitance			1480		pF		
Coss	Output Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =20V, f=1MHz f=1MHz			245		pF	
C <sub>rss</sub>	Reverse Transfer Capacitance				13		pF	
$R_g$	Gate resistance			0.9	1.8	2.7	Ω	
SWITCHI	NG PARAMETERS	•	•		•	•	•	
<b>Q</b> <sub>g</sub> (10V)	Total Gate Charge				20	30	nC	
Q <sub>g</sub> (4.5V)	Total Gate Charge	\/ =10\/ \/ =20\/	1 -204		8.5	14	nC	
$Q_{gs}$	Gate Source Charge	-V <sub>GS</sub> =10V, V <sub>DS</sub> =20V, I <sub>D</sub> =20A			5.5		nC	
$Q_{gd}$	Gate Drain Charge				3		nC	
Q <sub>oss</sub>	Output Charge	$V_{GS}$ =0V, $V_{DS}$ =20V	V <sub>GS</sub> =0V, V <sub>DS</sub> =20V		10		nC	
t <sub>D(on)</sub>	Turn-On DelayTime				7.5		ns	
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =20V, $R_L$ =1.0 $\Omega$ , $R_{GEN}$ =3 $\Omega$			2		ns	
t <sub>D(off)</sub>	Turn-Off DelayTime				23		ns	
t <sub>f</sub>	Turn-Off Fall Time				3		ns	
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, di/dt=500A/μs			11		ns	
$Q_{rr}$	Body Diode Reverse Recovery Charge	I <sub>F</sub> =20A, di/dt=500A/μs			21		nC	

A. The value of R<sub>BJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25° C. The Power dissipation P<sub>DSM</sub> is based on R <sub>8JA</sub> t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

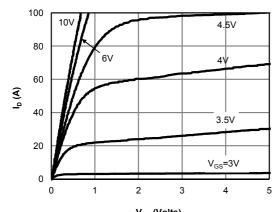
C. Single pulse width limited by junction temperature  $T_{J(\text{MAX})}\text{=}150^{\circ}\,$  C.

D. The  $R_{\text{NJA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{NJC}}$  and case to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300 $\mu$ s pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating. G. The maximum current rating is package limited.

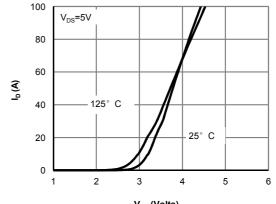
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.



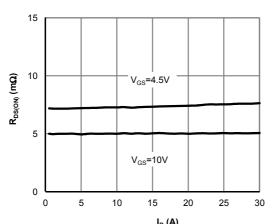
### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



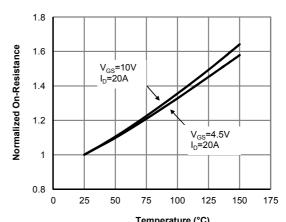
V<sub>DS</sub> (Volts) Figure 1: On-Region Characteristics (Note E)



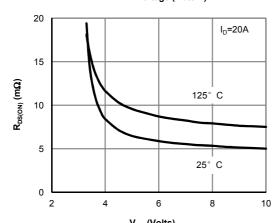
V<sub>GS</sub> (Volts) Figure 2: Transfer Characteristics (Note E)



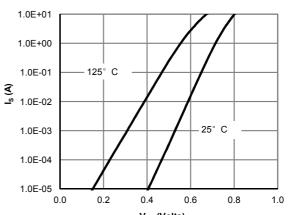
 $\label{eq:local_local} \textbf{I}_{\text{D}}\left(\textbf{A}\right)$  Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



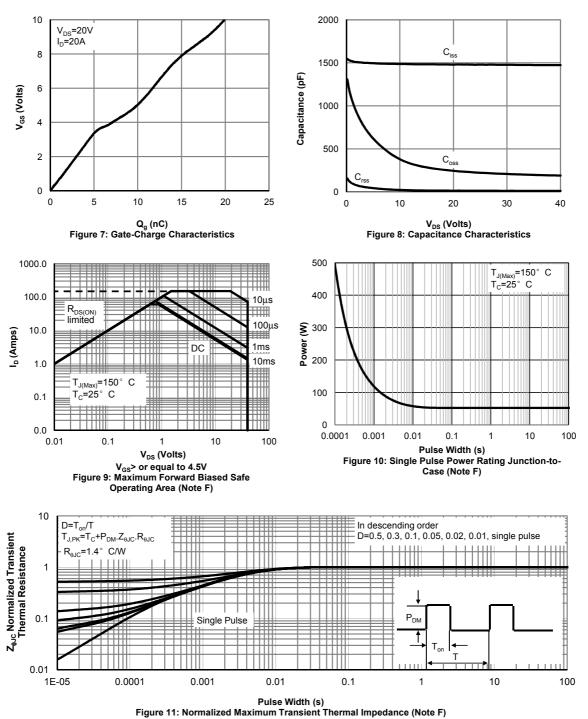
V<sub>GS</sub> (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)

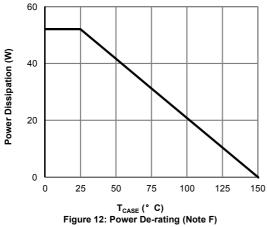


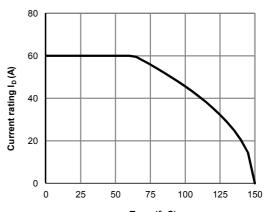
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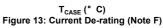


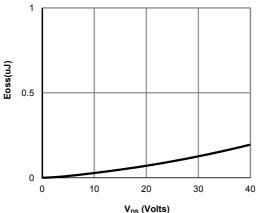


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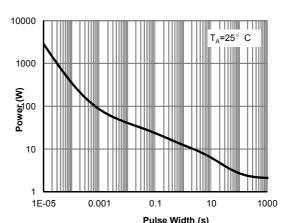




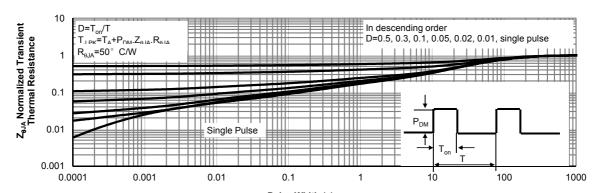




V<sub>DS</sub> (Volts) Figure 14: Coss stored Energy



Pulse Width (s)
Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

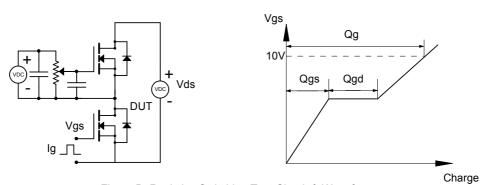


Figure B: Resistive Switching Test Circuit & Waveforms

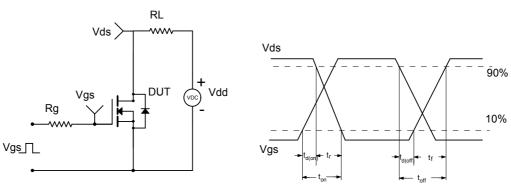


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

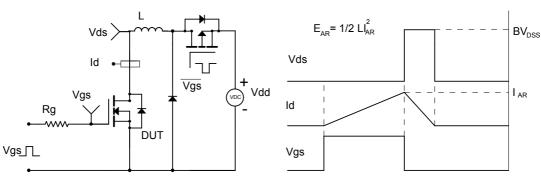
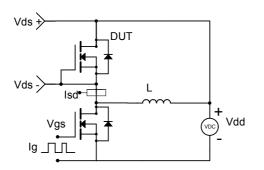
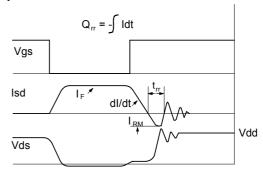


Figure D: Diode Recovery Test Circuit & Waveforms





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